Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/765,236	RATH, MATTHIAS	
Examiner	Art Unit	

Brian S. Kwon

1614

SEARCHED					
Class	Subclass	Date	Examiner		
514	474	3/6/2006	ВК		
	725				
	458		1		
	249				
	251				
	168				
424	655				
	641				
	630				
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	640				
	602	1			
	614				
updated		V	4		

INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE:	EXMR		
STN(resistry, caplus), EAST, NPL	3/26/2006	вьк		
Continurity Data-09/70609				
Inventor Name Search				
updated	J	0		
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